

# NBXSBB023, NBXSBA023

## 3.3 V, 400 MHz LVPECL Clock Oscillator

The NBXSBB023/NBXSBA023 single frequency crystal oscillator (XO) is designed to meet today's requirements for 3.3 V LVPECL clock generation applications. The device uses a high Q fundamental crystal and Phase Lock Loop (PLL) multiplier to provide 400 MHz, ultra low jitter and phase noise LVPECL differential output.

This device is a member of ON Semiconductor's PureEdge™ clock family that provides accurate and precision clock solutions.

Available in 5 mm x 7 mm SMD (CLCC) package on 16 mm tape and reel in quantities of 1,000. Frequency stability option available as either 50 PPM NBXSBA023 or 20 PPM NBXSBB023.

### Features

- LVPECL Differential Output
- Uses High Q Fundamental Mode Crystal and PLL Multiplier
- Ultra Low Jitter and Phase Noise – 0.5 ps (12 kHz – 20 MHz)
- Hermetically Sealed Ceramic SMD Package
- RoHS Compliant
- Operating Range 3.3 V  $\pm 10\%$
- Total Frequency Stability –  $\pm 20$  PPM or  $\pm 50$  PPM

### Applications

- Networking
- SPI-4

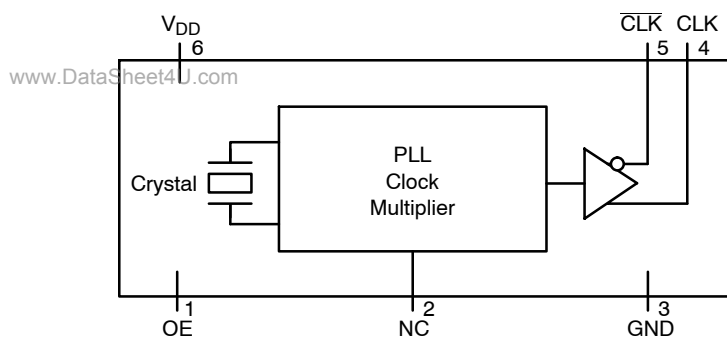
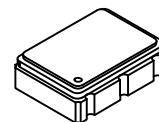


Figure 1. Simplified Logic Diagram



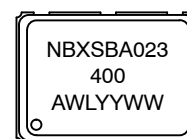
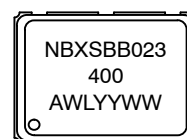
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**6 PIN CLCC  
TBD SUFFIX  
CASE 848AB**

### MARKING DIAGRAMS



NBXSBB023 = NBXSBB023 ( $\pm 20$  PPM)\*  
 NBXSBA023 = NBXSBA023 ( $\pm 50$  PPM)  
 400 = Output Frequency (MHz)  
 A = Assembly Location  
 WL = Wafer Lot  
 YY = Year  
 WW = Work Week

### ORDERING INFORMATION

Device	Package	Shipping†
NBXSBB023LN1TAG*	CLCC-6 (Pb-Free)	1000/ Tape & Reel
NBXSBA023LN1TAG	CLCC-6 (Pb-Free)	1000/ Tape & Reel
NBXSBA023LNHTAG	CLCC-6 (Pb-Free)	100/ Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

\* Please contact factory for availability

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

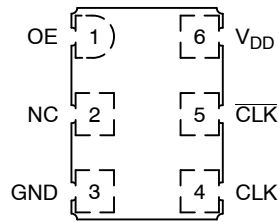


Figure 2. Pin Connections (Top View)

Table 1. PIN DESCRIPTION

Pin No.	Symbol	I/O	Description
1	OE	LVTTTL/LVCMOS Control Input	Output Enable Pin. When left floating pin defaults to logic HIGH and output is active. See OE pin description Table 2.
2	NC	–	No Connect.
3	GND	Power Supply	Ground 0 V.
4	CLK	LVPECL Output	Non-Inverted Clock Output. Typically loaded with 50 $\Omega$ receiver termination resistor to $V_{TT} = V_{DD} - 2$ V.
5	$\overline{\text{CLK}}$	LVPECL Output	Inverted Clock Output. Typically loaded with 50 $\Omega$ receiver termination resistor to $V_{TT} = V_{DD} - 2$ V.
6	V <sub>DD</sub>	Power Supply	Positive power supply voltage. Voltage should not exceed 3.3 V $\pm 10\%$ .

Table 2. OUTPUT ENABLE TRI-STATE FUNCTION

OE Pin	Output Pins
Open	Active
HIGH Level	Active
LOW Level	High Z

Table 3. ATTRIBUTES

Characteristic	Value
Input Default State Resistor	170 k $\Omega$
ESD Protection Human Body Model	2 kV
Machine Model	200 V
Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test	

1. For additional Moisture Sensitivity information, refer to Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Units
V <sub>DD</sub>	Positive Power Supply	GND = 0 V		4.6	V
I <sub>out</sub>	LVPECL Output Current	Continuous Surge		25 50	mA
T <sub>A</sub>	Operating Temperature Range			–40 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			–55 to +120	°C
T <sub>sol</sub>	Wave Solder	See Figure 5		260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

**Table 5. DC CHARACTERISTICS** ( $V_{DD} = 3.3 \text{ V} \pm 10\%$ ,  $GND = 0 \text{ V}$ ,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ )

Symbol	Characteristic	Conditions	Min.	Typ.	Max.	Units
$I_{DD}$	Power Supply Current (Note 2)			85	100	mA
$V_{IH}$	OE Input HIGH Voltage		2000		$V_{DD}$	mV
$V_{IL}$	OE Input LOW Voltage		$GND - 300$		800	mV
$I_{IH}$	Input HIGH Current OE		-100		+100	$\mu\text{A}$
$I_{IL}$	Input LOW Current OE		-100		+100	$\mu\text{A}$
$V_{OH}$	Output HIGH Voltage (Note 2)	$V_{DD} = 3.3 \text{ V}$	$V_{DD}-1145$ 2155		$V_{DD}-895$ 2405	mV
$V_{OL}$	Output LOW Voltage (Note 2)	$V_{DD} = 3.3 \text{ V}$	$V_{DD}-1945$ 1355		$V_{DD}-1600$ 1700	mV
$V_{OUTPP}$	Output Voltage Amplitude (Note 2)			680		mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

2. Measurement taken with outputs terminated with 50 ohm to  $V_{DD}-2 \text{ V}$ .

**Table 6. AC CHARACTERISTICS** ( $V_{DD} = 3.3 \text{ V} \pm 10\%$ ,  $GND = 0 \text{ V}$ ,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ) (Note 3)

Symbol	Characteristic	Conditions	Min.	Typ.	Max.	Units
$f_{CLKOUT}$	Output Clock Frequency			400		MHz
$\Delta f$	Frequency Stability – NBXSBB023 – NBXSBA023	$0^\circ\text{C}$ to $+70^\circ\text{C}$ $-40^\circ\text{C}$ to $+85^\circ\text{C}$ (Note 4)			$\pm 20$ $\pm 50$	PPM
$\Phi_{NOISE}$	Phase-Noise Performance $f_{CLKout} = 400 \text{ MHz}$	100 Hz of Carrier		-99		dBc/Hz
		1 kHz of Carrier		-115		dBc/Hz
		10 kHz of Carrier		-121		dBc/Hz
		100 kHz of Carrier		-123		dBc/Hz
		1 MHz of Carrier		-131		dBc/Hz
		10 MHz of Carrier		-157		dBc/Hz
$t_{jit}(\Phi)$	RMS Phase Jitter	12 kHz to 20 MHz		0.5	0.9	ps
$t_{jitter}$	Cycle to Cycle, RMS	1000 Cycles		2.5	15	ps
	Cycle to Cycle, Peak-to-Peak	1000 Cycles		14	40	ps
	Period, RMS	10,000 Cycles		1.5	7.0	ps
	Period, Peak-to-Peak	10,000 Cycles		9	30	ps
$t_{OE/OD}$	Output Enable/Disable Time				200	ns
$t_{DUTY\_CYCLE}$	Output Clock Duty Cycle (Measured at Cross Point)		48	50	52	%
$t_R$	Output Rise Time (20% and 80%)			250		ps
$t_F$	Output Fall Time (80% and 20%)			250		ps
$t_{start}$	Start-up Time			1	5	ms
	Aging	1 <sup>st</sup> Year			3	ppm
		Every Year After 1 <sup>st</sup>			1	ppm

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

3. Measurement taken with outputs terminated with 50 ohm to  $V_{DD}-2 \text{ V}$ .

4. Parameter guarantees 10 years of aging. Includes initial stability at  $25^\circ\text{C}$ , shock, vibration, and first year aging.

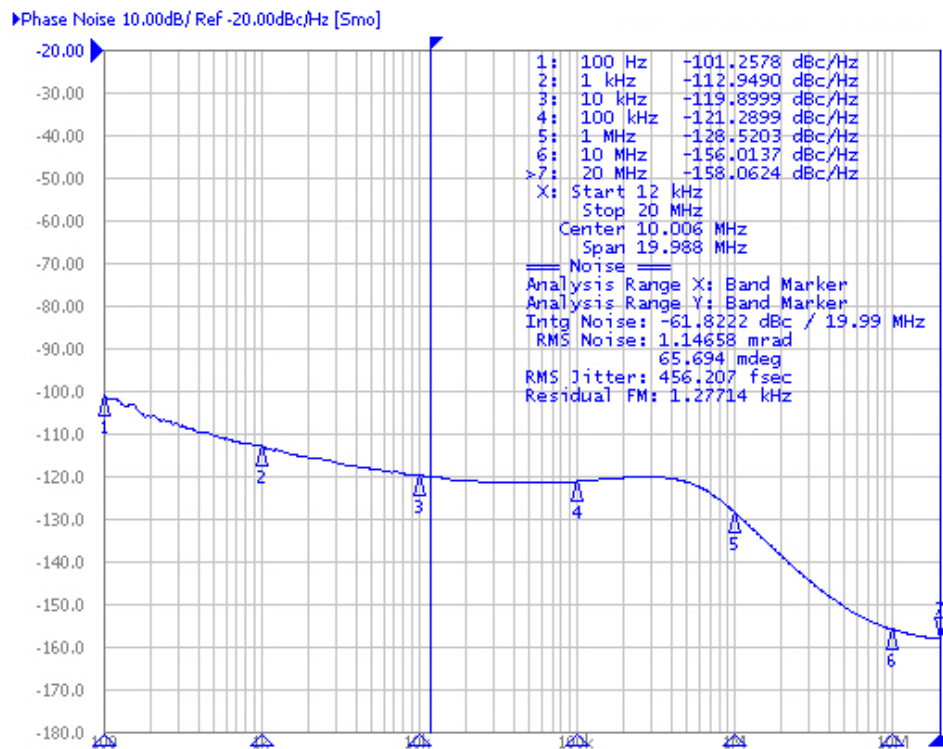
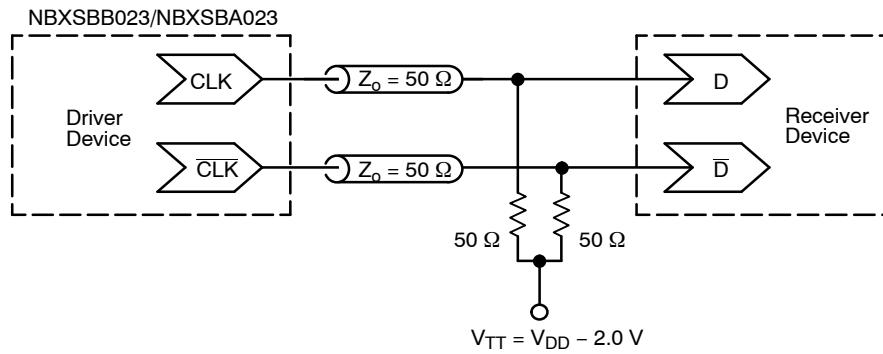


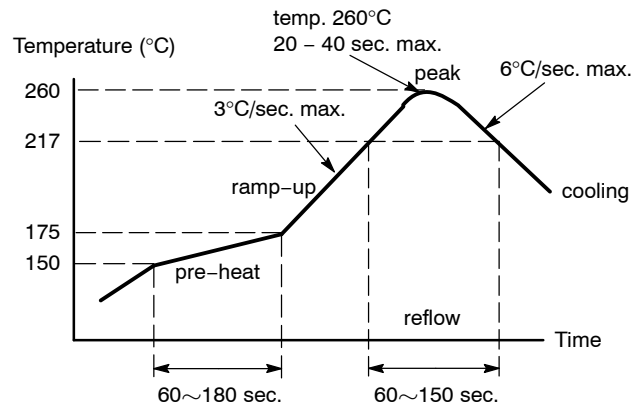
Figure 3. Typical Phase Noise Plot

Table 7. RELIABILITY COMPLIANCE

Parameter	Standard	Method
Shock	Mechanical	MIL-STD-833, Method 2002, Condition B
Solderability	Mechanical	MIL-STD-833, Method 2003
Vibration	Mechanical	MIL-STD-833, Method 2007, Condition A
Solvent Resistance	Mechanical	MIL-STD-202, Method 215
Thermal Shock	Environment	MIL-STD-833, Method 1011, Condition A
Moisture Level Sensitivity	Environment	MSL1 260°C per IPC/JEDEC J-STD-020D

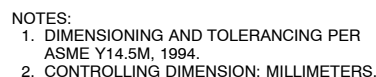


**Figure 4. Typical Termination for Output Driver and Device Evaluation**  
(See Application Note AND8020/D – Termination of ECL Logic Devices.)



**Figure 5. Recommended Reflow Soldering Profile**


**6 PIN CLCC, 7x5, 2.54P**  
CASE 848AB-01  
ISSUE A



DIM	MILLIMETERS		
	MIN	NOM	MAX
A	1.70	1.80	1.90
A1	0.70 REF		
A2	0.36 REF		
A3	0.08	0.10	0.12
b	1.30	1.40	1.50
D	7.00 BSC		
D1	6.17	6.20	6.23
D2	6.66	6.81	6.96
D3	5.08 BSC		
E	5.00 BSC		
E1	4.37	4.40	4.43
E2	4.65	4.80	4.95
E3	3.49 BSC		
e	2.54 BSC		
L	1.17	1.27	1.37
R	0.70 REF		

Diagram illustrating the dimensions of a 2x3 grid of square cells. The grid is defined by dashed lines. The vertical spacing between rows is labeled  $6 \times 1.50$  on the left and  $5.06$  on the right. The horizontal spacing between columns is labeled  $2.54$  on the left and  $6 \times 1.50$  on the right. The text "DIMENSION: MILLIMETERS" is at the bottom right.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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